

FORM PTO 1449 (modified)		ATTY DOCKET NO. 2004_1604A	SERIAL NO. NEW 10/511751
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICANT Takuji MAEDA et al.	
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		FILING DATE October 19, 2004	GROUP 2134
Date Submitted to PTO: October 19, 2004			

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/Y.B./	AG	8-190529	7/1996	JP			Abstract
/Y.B./	AH	2000-242491	9/2000	JP			Abstract
/Y.B./	AI	2002-091772	3/2002	JP			Abstract
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	AO	
	AP	
	AQ	

EXAMINER /Yonas Bayou/

DATE CONSIDERED

01/02/2008

INFORMATION DISCLOSURE STATEMENT

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
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Date Submitted to PTO: May 2, 2006

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/Y.B./	AO	Bruce Schneier, John Wiley & Sons, Inc., "Applied Cryptography", 1996, pp. 34-41
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EXAMINER

/Yonas Bayou/

DATE CONSIDERED

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